



PATENT  
ATTORNEY DOCKET NO. 0075/021001

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants: Detlef KNEBEL et al. Art Unit: 2881  
Application No.: 10/521,563 Examiner: Logie, M.  
Title: METHOD FOR LOCALLY HIGHLY RESOLVED, MASS-SPECTROSCOPIC  
CHARACTERIZATION OF SURFACES USING SCANNING PROBE  
TECHNOLOGY

International Application No.: PCT/DE2003/002493  
International Filing Date : July 24, 2003  
Priority Date : July 24, 2002  
U.S. Filing Date : January 19, 2005

**Mail Stop Amendment**

Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

AMENDMENT UNDER 37 CFR 1.111

Sir:

In response to the Office Action dated February 1, 2008,  
please amend the application as follows:

Amendments to the Claims begin on page 2 of this paper.

Remarks begin on page 9 of this paper.